

	Type	Hits	Search Text	DBs	Time Stamp	Comments	Error Definiti on
1	IS&R	2	("6397361").PN.	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/10/19 11:25		
2	BRS	84	chip-to-package	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/10/19 09:14		
3	BRS	337	test\$3 with semiconductor\$1 with i/o	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/10/19 09:44		
4	BRS	5196	324/713,763,765,538,711.cc ls.	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/10/18 17:18		
5	BRS	773	702/117,118.cc1s.	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/10/18 17:18		

	Type	Hits	Search Text	DBs	Time Stamp	Comments	Error Definition
6	BRS	4	(test\$3 or detect\$3) with connect\$5 with (I/O or input/output) with (semiconductor\$1 or IC\$1 or wafer\$1 or (integrated adj circuit\$1)) and (differen\$2 or compar\$4) with (threshold\$1 or predetermined or reference) and (switch\$3 or latch\$2) and package\$1 with chip\$1 and driver\$1 with receiver\$1	USPAT; US-PGPUB; EPO; 2004/10/18 JPO; DERWENT; 17:20 IBM_TDB			
7	BRS	837	702/117,118.ccls.	USPAT; US-PGPUB; EPO; 2004/10/18 JPO; DERWENT; 17:18 IBM_TDB			
8	BRS	5406	324/713,763,765,538,711.ccls.	USPAT; US-PGPUB; EPO; 2004/10/18 JPO; DERWENT; 17:18 IBM_TDB			

	Type	Hits	Search Text	DBs	Time Stamp	Comments	Error Definition
9	BRS	5	(test\$3 or detect\$3) with connect\$5 with (I/O or input/output) with (semiconductor\$1 or IC\$1 or wafer\$1 or (integrated adj circuit\$1)) and (differen\$2 or compar\$4) with (threshold\$1 or predetermined or reference) and (switch\$3 or latch\$2) and package\$1 with chip\$1 and driver\$1 with receiver\$1	USPAT; US-PGPUB; EPO; 2004/10/18 JPO; DERWENT; 17:21 IBM_TDB			
10	BRS	2	"20040153276"	USPAT; US-PGPUB; EPO; 2004/10/19 JPO; DERWENT; 08:13 IBM_TDB			
11	IS&R	16	((("6058496") or ("5923676") or ("5736862") or ("5502392") or ("5278841") or ("5268645") or ("5265901") or ("4565966"))).PN.	USPAT; US-PGPUB; EPO; 2004/10/19 JPO; DERWENT; 10:40 IBM_TDB			
12	BRS	33	324/\$.cccls. and tang.xp.	USPAT; US-PGPUB; EPO; 2004/10/19 JPO; DERWENT; 09:27 IBM_TDB			

	Type	Hits	Search Text	DBs	Time Stamp	Comments	Error Definiti on
13	BRS	367	test\$3 with semiconductor\$1 with i/o	USPAT; US-PGPUB; EPO; 2004/10/19 JPO; DERWENT; IBM_TDB	2004/10/19 09:44		
14	BRS	1589	test\$3 with semiconductor\$1 with (input adj output or i/o)	USPAT; US-PGPUB; EPO; 2004/10/19 JPO; DERWENT; IBM_TDB	2004/10/19 09:45		
15	BRS	0	test\$3 with semiconductor\$1 with (input adj output or i/o) and connect\$5 with chip\$1 with package\$1	USPAT; US-PGPUB; EPO; 2004/10/19 JPO; DERWENT; IBM_TDB	2004/10/19 09:46		
16	BRS	93	test\$3 with semiconductor\$1 with (input adj output or i/o) and connect\$5 with chip\$1 with package\$1	USPAT; US-PGPUB; EPO; 2004/10/19 JPO; DERWENT; IBM_TDB	2004/10/19 09:46		
17	BRS	3	test\$3 with semiconductor\$1 with (input adj output or i/o) and connect\$5 with chip\$1 with package\$1 and (start\$3 or initiz\$5) with (latch\$3 or switch\$) with transition\$1	USPAT; US-PGPUB; EPO; 2004/10/19 JPO; DERWENT; IBM_TDB	2004/10/19 09:48		

	Type	Hits	Search Text	DBs	Time Stamp	Comments	Error Definition
18	BRS	7	test\$3 with semiconductor\$1 with (input adj output or i/o) and connect\$5 with chip\$1 with package\$1 and (start\$3 or initiz\$5) with (latch\$3 or switch\$)	USPAT; US-PGPUB; EPO; 2004/10/19 JPO; DERWENT; IBM_TDB	2004/10/19 09:51		
19	BRS	4	test\$3 with semiconductor\$1 with (input adj output or i/o) and connect\$5 with chip\$1 with package\$1 and (latch\$3 or switch\$) with (threshold\$1 or desired or expect\$2 or predetermin\$2 or preset\$4 or predefin\$2) with transition	USPAT; US-PGPUB; EPO; 2004/10/19 JPO; DERWENT; IBM_TDB	2004/10/19 09:52		
20	BRS	19	test\$3 with semiconductor\$1 with (input adj output or i/o) and connect\$5 with chip\$1 with package\$1 and (latch\$3 or switch\$) with (threshold\$1 or desired or expect\$2 or predetermin\$2 or preset\$4 or predefin\$2)	USPAT; US-PGPUB; EPO; 2004/10/19 JPO; DERWENT; IBM_TDB	2004/10/19 09:53		

Type	Hits	Search Text	DBs	Time Stamp	Comments	Error Definition
21 BRS	13	test\$3 with semiconductor\$1 with (input adj output or i/o) and connect\$5 with chip\$1 with package\$1 and (latch\$3 or switch\$) with (threshold\$1 or desired or expect\$2 or predetermined\$2 or preset\$4 or predefined\$2) and transition	USPAT; US-PGPUB; EPO; 2004/10/19 JPO; DERWENT; IBM_TDB	2004/10/19 09:56		
22 BRS	4	test\$3 with semiconductor\$1 with (input adj output or i/o) and connect\$5 with chip\$1 with package\$1 and transition with reach\$3 with (threshold\$1 or desired or expect\$2 or predetermined\$2 or preset\$4 or predefined\$2)	USPAT; US-PGPUB; EPO; 2004/10/19 JPO; DERWENT; IBM_TDB	2004/10/19 09:57		
23 BRS	4	test\$3 with semiconductor\$1 with (input adj output or i/o) and transition with reach\$3 with (threshold\$1 or desired or expect\$2 or predetermined\$2 or preset\$4 or predefined\$2)	USPAT; US-PGPUB; EPO; 2004/10/19 JPO; DERWENT; IBM_TDB	2004/10/19 13:09		

	Type	Hits	Search Text	DBs	Time Stamp	Comments	Error Definition
24	BRS	4	test\$3 with semiconductor\$1 with (input adj output or i/o) and connect\$5 with chip\$1 with package\$1 and transition with (threshold\$1 or desired or expect\$2 or predetermined\$2 or preset\$4 or predefined\$2)	USPAT; US-PGPUB; EPO; 2004/10/19 JPO; DERWENT; IBM_TDB	2004/10/19 09:58		
25	BRS	34	test\$3 with semiconductor\$1 with (input adj output or i/o) and transition with (threshold\$1 or desired or expect\$2 or predetermined\$2 or preset\$4 or predefined\$2)	USPAT; US-PGPUB; EPO; 2004/10/19 JPO; DERWENT; IBM_TDB	2004/10/19 09:58		
26	IS&R	2	("6260163").PN.	USPAT; US-PGPUB; EPO; 2004/10/19 JPO; DERWENT; IBM_TDB	2004/10/19 10:39		
27	IS&R	2	("6020752").PN.	USPAT; US-PGPUB; EPO; 2004/10/19 JPO; DERWENT; IBM_TDB	2004/10/19 10:39		
28	IS&R	2	("5602989").PN.	USPAT; US-PGPUB; EPO; 2004/10/19 JPO; DERWENT; IBM_TDB	2004/10/19 10:39		

	Type	Hits	Search Text	DBs	Time Stamp	Comments	Error Definition
29	IS&R	2	("5241264").PN.	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/10/19 10:40		
30	IS&R	8	((("6058496") or ("5923676") or ("5736862") or ("5502392") or ("5278841") or ("5268645") or ("5265901") or ("4565966"))).PN.	USPAT	2004/10/19 10:40		
31	IS&R	2	("6262580").PN.	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/10/19 11:37		
32	BRS	4	test\$3 with semiconductor\$1 with (input adj output or i/o) and impedance with connection with driver\$1	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/10/19 13:10		
33	BRS	4	test\$3 with semiconductor\$1 with (input adj output or i/o) and imped\$4 with connection with driver\$1	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/10/19 13:11		
34	BRS	2	test\$3 with semiconductor\$1 with (input adj output or i/o) and additional with imped\$4 with connect\$3 with driver\$1	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/10/19 13:11		